

2-Aminopyridinium–succinate–
succinic acid (2/1/1)Orhan Büyükgüngör^{a*} and Mustafa Odabaşoğlu^b^aDepartment of Physics, Ondokuz Mayıs University, TR-55139, Samsun, Turkey, and^bDepartment of Chemistry, Ondokuz Mayıs University, TR-55139, Samsun, Turkey

Correspondence e-mail: orhanb@omu.edu.tr

Received 19 July 2002

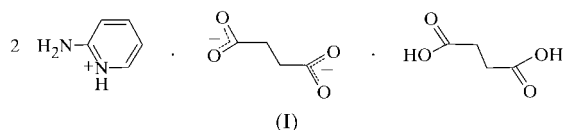
Accepted 30 September 2002

Online 31 October 2002

In the title compound, $2\text{C}_5\text{H}_7\text{N}_2^+ \cdot \text{C}_4\text{H}_4\text{O}_4^{2-} \cdot \text{C}_4\text{H}_6\text{O}_4$, cyclic eight-membered hydrogen-bonded rings exist involving 2-aminopyridinium and succinate ions. The succinic acid and succinate moieties lie on inversion centres. Succinic acid molecules and succinate ions are linked into zigzag chains by $\text{O}—\text{H} \cdots \text{O}$ hydrogen bonds, with $\text{O} \cdots \text{O}$ distances of 2.6005 (16) Å.

Comment

Hydrogen bonding plays a key role in molecular recognition (Goswami & Ghosh, 1997) and crystal engineering research (Goswami *et al.*, 1998). The design of highly specific solid-state structures is of considerable significance in organic chemistry, due to their important applications in the development of new optical, magnetic and electronic systems (Lehn, 1990). Our investigation of the title compound, (I), shows that the 2-aminopyridinium ions are linked to the succinate ions through $\text{N1}—\text{H} \cdots \text{O3}$ and $\text{N2}—\text{H2NA} \cdots \text{O4}$ hydrogen bonds, resulting in the formation of cyclic eight-membered hydrogen-bonded rings.



Each amino H atom in (I) is involved in a single hydrogen bond, one in the cyclic eight-membered hydrogen-bonded ring system and the other to another succinate ion (Fig. 1). The 2-aminopyridinium–succinate–succinic acid units are arranged so that a two-dimensional network of intermolecular $\text{N2}—\text{H2NB} \cdots \text{O4}$ and $\text{O2}—\text{H6} \cdots \text{O3}$ hydrogen bonds exists on each nearly perpendicular 2-aminopyridinium–succinate–succinic acid unit [dihedral angle = 84.34 (8)°] (Fig. 2).

2-Aminopyridine, like other organic bases, is protonated in acidic solutions. The bonding of the H atom to the ring N atom of 2-aminopyridine, but not to the amino N atom, gives an ion

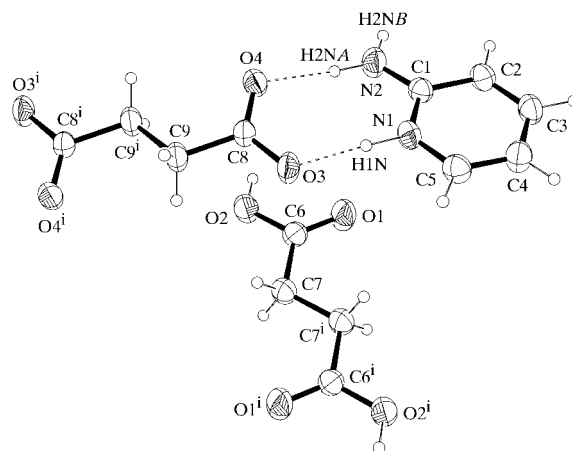


Figure 1

A view of the three moieties of (I), with the atom-numbering scheme and 50% probability displacement ellipsoids. H atoms are shown as small spheres of arbitrary radii [symmetry codes: (i) $-x, -y, -z$].

for which an additional resonance structure can be written. As this monocation has more resonance energy (additional ionic resonance) than 2-aminopyridine itself, 2-aminopyridine is a strong base, like amidines (Acheson, 1967).

The present investigation clearly shows that the positive charge in (I) is on the amino group in the crystal. The $\text{C1}—\text{N2}$ bond length is 1.3272 (19) Å, and this is approximately equal to a previously reported $\text{C}=\text{N}$ double-bond length (Shanmuga Sundara Raj, Fun, Lu *et al.*, 2000). The location of the positive charge on the amino group is also supported by the $\text{C1}—\text{N2}—\text{H2NA}$ angle of 118.4 (11)° and by the fact that atoms C1, N2, H2NA and H2NB lie in the pyridine plane, with a maximum deviation of 0.04 (2) Å for atom H2NB. Similar $\text{C1}—\text{N2}$ bond lengths have also been observed in other 2-aminopyridine-containing molecules (Yang *et al.*, 1995; Grobelny *et al.*, 1995; Shanmuga Sundara Raj, Fun, Zhao *et al.*, 2000).

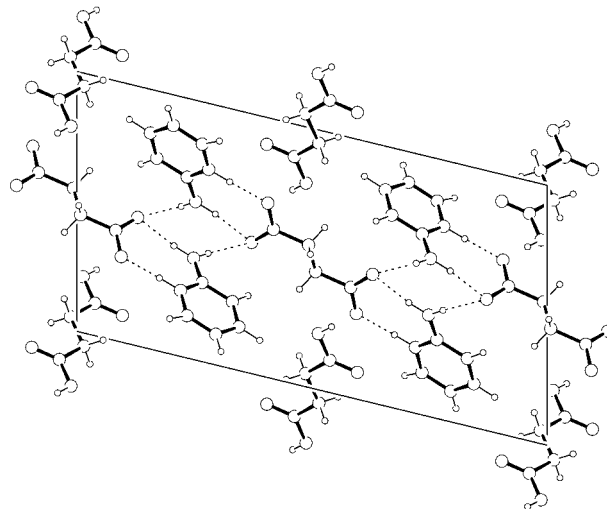


Figure 2

A packing diagram for (I), viewed along the *b* axis.

Experimental

The title compound was prepared by mixing 2-aminopyridine and succinic acid in a 1:1 molar ratio in water at 353 K. Crystals of (I) were obtained by slow evaporation of the solvent.

Crystal data

$2\text{C}_5\text{H}_7\text{N}_2^+ \cdot \text{C}_4\text{H}_4\text{O}_4^{2-} \cdot \text{C}_4\text{H}_6\text{O}_4$	$D_x = 1.436 \text{ Mg m}^{-3}$
$M_r = 424.41$	Mo $K\alpha$ radiation
Monoclinic, $P2_1/c$	Cell parameters from 35 reflections
$a = 10.228 (2) \text{ \AA}$	$\theta = 5\text{--}25^\circ$
$b = 5.1840 (10) \text{ \AA}$	$\mu = 0.11 \text{ mm}^{-1}$
$c = 19.047 (4) \text{ \AA}$	$T = 153 (2) \text{ K}$
$\beta = 103.60 (3)^\circ$	Rectangular, light yellow
$V = 981.6 (4) \text{ \AA}^3$	$0.3 \times 0.2 \times 0.2 \text{ mm}$
$Z = 2$	

Data collection

Siemens P4 diffractometer	$h = -13 \rightarrow 13$
ω scans	$k = 0 \rightarrow 6$
2362 measured reflections	$l = 0 \rightarrow 25$
2362 independent reflections	1 standard reflection
1690 reflections with $I > 2\sigma(I)$	frequency: 120 min
$\theta_{\text{max}} = 28^\circ$	intensity decay: none

Table 1

Selected geometric parameters (\AA , $^\circ$).

C1—N2	1.3272 (19)	O2—C6	1.3123 (17)
C1—N1	1.3500 (18)	O3—C8	1.2747 (16)
N1—C5	1.3578 (19)	O4—C8	1.2413 (16)
O1—C6	1.2038 (17)		
O1—C6—O2	123.44 (14)	O4—C8—O3	122.95 (12)
N2—C1—N1—C5	178.53 (14)	O4—C8—C9—C9 ⁱⁱ	11.1 (3)
O1—C6—C7—C7 ⁱ	2.6 (3)	O3—C8—C9—C9 ⁱⁱ	-169.72 (18)
O2—C6—C7—C7 ⁱ	-177.09 (18)		

Symmetry codes: (i) $-x, 1 - y, 1 - z$; (ii) $1 - x, 1 - y, 1 - z$.

Table 2

Hydrogen-bonding geometry (\AA , $^\circ$).

$D\text{—}H \cdots A$	$D\text{—}H$	$H \cdots A$	$D \cdots A$	$D\text{—}H \cdots A$
N1—H1N \cdots O3	0.969 (18)	1.751 (18)	2.7185 (16)	176.0 (17)
N2—H2NA \cdots O4	0.929 (18)	1.936 (19)	2.8521 (18)	168.2 (16)
N2—H2NB \cdots O4 ⁱ	0.84 (2)	2.11 (2)	2.9447 (19)	167.7 (17)
O2—H6 \cdots O3 ⁱⁱ	0.89 (2)	1.72 (2)	2.6005 (16)	178 (2)

Symmetry codes: (i) $1 - x, y - \frac{1}{2}, z$; (ii) $x, y - 1, z$.

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0496P)^2 + 0.0805P]$
$R[F^2 > 2\sigma(F^2)] = 0.037$	where $P = (F_o^2 + 2F_c^2)/3$
$wR(F^2) = 0.104$	$(\Delta/\sigma)_{\text{max}} = 0.001$
$S = 1.02$	$\Delta\rho_{\text{max}} = 0.29 \text{ e \AA}^{-3}$
2362 reflections	$\Delta\rho_{\text{min}} = -0.19 \text{ e \AA}^{-3}$
185 parameters	Extinction correction: <i>SHELXL97</i>
All H-atom parameters refined	Extinction coefficient: 0.015 (3)

All H-atom parameters were freely refined, with C—H distances in the range 0.92 (2)–0.982 (15) \AA and $U_{\text{iso}}(\text{H})$ values in the range 0.039 (4)–0.075 (6) \AA^2 .

Data collection: *XSCANS* (Siemens, 1991); cell refinement: *XSCANS*; data reduction: *SHELXTL* (Bruker, 2001); program(s) used to solve structure: *SHELXS97* (Sheldrick, 1997); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *ORTEPIII* (Burnett & Johnson, 1996); software used to prepare material for publication: *WinGX* (Farrugia, 1997).

The authors wish to thank Professor Dr D. Fenske for the opportunity to use the diffractometer and computer facilities of the Institut für Anorganische Chemie der Universität Karlsruhe, Germany, and Dr G. Helmut for his kind assistance during data handling.

Supplementary data for this paper are available from the IUCr electronic archives (Reference: FR1391). Services for accessing these data are described at the back of the journal.

References

- Acheson, R. M. (1967). *An Introduction to the Chemistry of Heterocyclic Compounds*, 2nd ed., pp. 215–218. London: Wiley.
- Bruker (2001). *SHELXTL*. Version 6.12. Bruker AXS Inc., Madison, Wisconsin, USA.
- Burnett, M. N. & Johnson, C. K. (1996). *ORTEPIII*. Report ORNL-6895. Oak Ridge National Laboratory, Tennessee, USA.
- Farrugia, L. J. (1997). *WinGX*. 16-bit Version. University of Glasgow, Scotland.
- Goswami, S. P. & Ghosh, K. (1997). *Tetrahedron Lett.* **38**, 4503–4506.
- Goswami, S. P., Mahapatra, A. K., Nigam, G. D., Chinnakali, K. & Fun, H.-K. (1998). *Acta Cryst.* **C54**, 1301–1302.
- Grobelyny, R., Glowiak, T., Mrozinski, J., Baran, W. & Tomasik, P. (1995). *Pol. J. Chem.* **69**, 559–565.
- Lehn, J. M. (1990). *Angew. Chem. Int. Ed. Engl.* **29**, 1304–1311.
- Shanmuga Sundara Raj, S., Fun, H.-K., Lu, Z.-L., Xiao, W., Gong, X.-Y. & Gen, C.-M. (2000). *Acta Cryst.* **C56**, 1015–1016.
- Shanmuga Sundara Raj, S., Fun, H.-K., Zhao, P.-S., Jian, F.-F., Lu, L.-D., Yang, X.-J. & Wang, X. (2000). *Acta Cryst.* **C56**, 742–743.
- Sheldrick, G. M. (1997). *SHELXS97* and *SHELXL97*. University of Göttingen, Germany.
- Siemens (1991). *XSCANS User's Manual*. Version 2.10b. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.
- Yang, R. N., Wang, D. M., Hou, Y. M., Xue, B. Y., Jin, D. M., Chen, L. R. & Luo, B. S. (1995). *Acta Chem. Scand.* **49**, 771–773.